

UNISONIC TECHNOLOGIES CO., LTD

16N50 **Preliminary Power MOSFET**

16 A, 500 V N-CHANNEL POWER MOSFET

DESCRIPTION

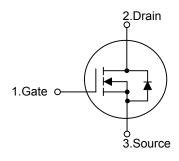
The UTC 16N50 is an N-channel mode power MOSFET using UTC's advanced technology to provide customers with planar stripe and DMOS technology. This technology allows a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

The UTC 16N50 is generally applied in high efficiency switch mode power supplies, active power factor correction and electronic lamp ballasts based on half bridge topology.

FEATURES

- * $R_{DS(ON)}$ <0.38 Ω @ V_{GS} =10V
- * High Switching Speed
- * 100% Avalanche Tested

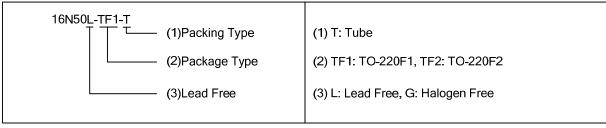
SYMBOL

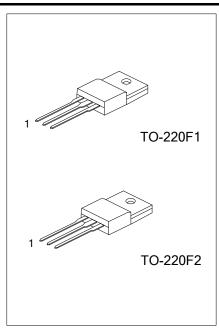


ORDERING INFORMATION

Ordering Number		Doolsono	Pin	Daakina			
Lead Free	Halogen Free	Package	1	2	3	Packing	
16N50L-TF1-T	16N50G-TF1-T	TO-220F1	G	D	S	Tube	
16N50L-TF2-T	16N50G-TF2-T	TO-220F2	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source





www.unisonic.com.tw 1 of 6

■ ABSOLUTE MAXIMUM RATINGS (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V_{DSS}	500	V	
Gate-Source Voltage		V_{GSS}	±30	V	
Davis O seed	Continuous (T _C =25°C)	I_{D}	16 (Note 2)	Α	
Drain Current	Pulsed (Note 3)	I _{DM}	64 (Note 2)	Α	
Avalanche Current (Note 3)		I _{AR}	16	Α	
Avalanche Energy	Single Pulsed (Note 4)	E _{AS}	780	mJ	
	Repetitive (Note 5)	E _{AR}	20	mJ	
Peak Diode Recovery dv/dt (Note 5)		dv/dt	4.5	V/ns	
D D: : // /T 0500\	TO-220F1		52	10/	
Power Dissipation (T _C =25°C)	TO-220F2	P_{D}	62	W	
Linear Derating Factor above	rating Factor above TO-220F1		0.41	14400	
T _C =25°C	TO-220F2		0.31	W/°C	
Junction Temperature		TJ	+150	°C	
Storage Temperature		T _{STG}	-55~+150	°C	

Note: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Drain current limited by maximum junction temperature
- 3. Repetitive Rating: Pulse width limited by maximum junction temperature
- 4. L = 6.1mH, I_{AS} = 16A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25 $^{\circ}$ C
- 5. $I_{SD} \le 16A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT	
Junction to Ambient		θ_{JA}	JA 62.5		
Junction to Case	TO-220F1	0	2.4	°0///	
	TO-220F2	θјс	2.0	°C/W	

■ ELECTRICAL CHARACTERISTICS (T_C=25°C, unless otherwise specified)

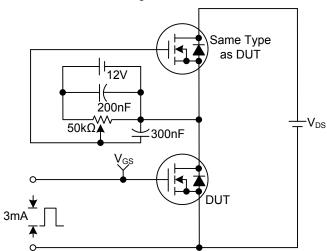
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS				•	•		
Drain-Source Breakdown Voltage		BV _{DSS}	I _D =250μA, V _{GS} =0V	500			V
Drain-Source Leakage Current		I _{DSS}	V _{DS} =500V, V _{GS} =0V			1	μΑ
			V _{DS} =400V, V _{GS} =0V, T _C =125°C			10	μΑ
Gate- Source Leakage Current	Forward		V_{GS} =+30V, V_{DS} =0V			+100	nA
	Reverse	I _{GSS}	V_{GS} =-30V, V_{DS} =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$			4.0	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =8A		0.31	0.38	Ω
DYNAMIC PARAMETERS							
nput Capacitance		C _{ISS}	V _{GS} =0V, V _{DS} =25V, f=1.0MHz		1495	1945	pF
Output Capacitance		Coss			235	310	pF
Reverse Transfer Capacitance		C_{RSS}			20	30	pF
SWITCHING PARAMETERS							
Total Gate Charge		Q_{G}	V _{GS} =10V, V _{DS} =400V, I _D =16A (Note 6, 7)		32	45	nC
Gate to Source Charge		Q_{GS}			8.5		nC
Gate to Drain Charge		Q_{GD}			14		nC
Turn-ON Delay Time		t _{D(ON)}	V _{DD} =250V, I _D =16A, R _G =25Ω (Note 6, 7)		40	90	ns
Rise Time		t _R			150	310	ns
Turn-OFF Delay Time		$t_{D(OFF)}$			65	140	ns
Fall-Time		t_{F}			80	170	ns
SOURCE- DRAIN DIODE RATIN	IGS AND (CHARACTERI	STICS				
Maximum Body-Diode Continuous Current		Is				9.2	Α
Maximum Body-Diode Pulsed Current		I _{SM}				37	Α
Drain-Source Diode Forward Voltage		V_{SD}	I _S =16A, V _{GS} =0V			1.4	V
Body Diode Reverse Recovery Time		t _{RR}	_I _S =16A, V _{GS} =0V, dI _F /dt=100A/μs		490		ns
Body Diode Reverse Recovery Charge		Q_{RR}	(Note 6)		5.0		μC

Notes: 6. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%

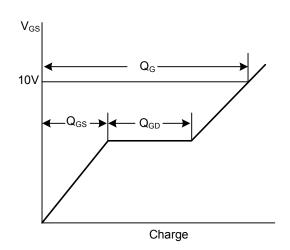
^{7.} Essentially independent of operating temperature

■ TEST CIRCUITS AND WAVEFORMS

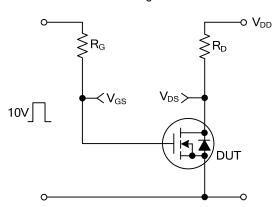
Gate Charge Test Circuit



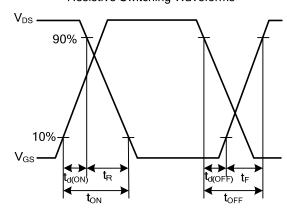
Gate Charge Waveforms



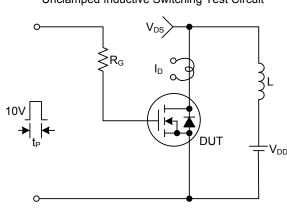
Resistive Switching Test Circuit



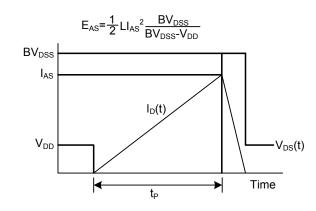
Resistive Switching Waveforms



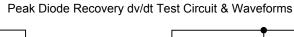
Unclamped Inductive Switching Test Circuit

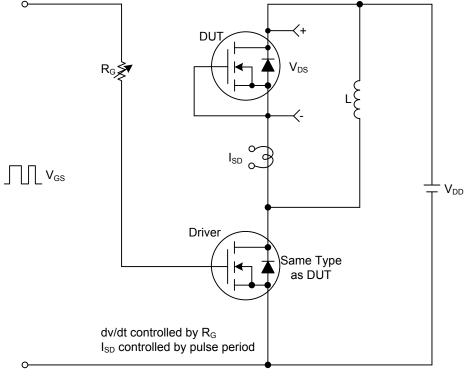


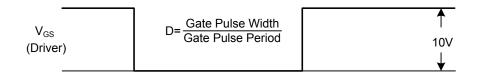
Unclamped Inductive Switching Waveforms

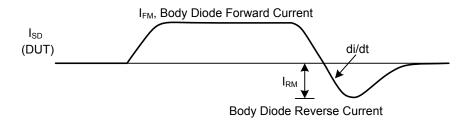


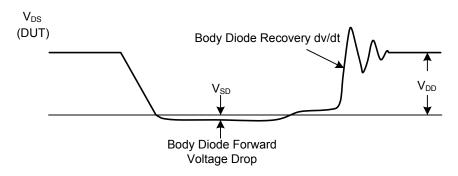
■ TEST CIRCUITS AND WAVEFORMS(Cont.)











UTC assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all UTC products described or contained herein. UTC products are not designed for use in life support appliances, devices or systems where malfunction of these products can be reasonably expected to result in personal injury. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner. The information presented in this document does not form part of any quotation or contract, is believed to be accurate and reliable and may be changed without notice.

